

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/604,894	CHANG ET AL.	
Examiner	Art Unit	
Haissa Philogene	2828	

SEARCHED				
Class	Subclass	Date	Examiner	
315 	169.3, 169.2	3/3/2005	HP	
	291, 224			
	307, 362			
	149, 312			
345	74.1, 81			
	82, 84			
	87, 98			
	102, 204			
	207			
362	27, 276			
	555, 802			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
315	169,3	3/4/05	4P		
L	29/ 224		1		
345	102,81				
	207				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
West Search	3/3/2005	' hp		
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